

## CoolMOS™ Power Transistor

### Features

- Lowest figure-of-merit  $R_{ON} \times Q_g$
- Extreme dv/dt rated
- High peak current capability
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Pb-free lead plating; RoHS compliant
- Ultra low gate charge

### CoolMOS™ 900V is designed for:

- Quasi Resonant Flyback / Forward topologies
- PC Silverbox and consumer applications
- Industrial SMPS

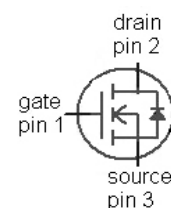
### Product Summary

|                                           |     |          |
|-------------------------------------------|-----|----------|
| $V_{DS} @ T_J=25^{\circ}\text{C}$         | 900 | V        |
| $R_{DS(on),max} @ T_J=25^{\circ}\text{C}$ | 0.8 | $\Omega$ |
| $Q_{g,typ}$                               | 42  | nC       |

PG-T0247



| Type        | Package  | Marking |
|-------------|----------|---------|
| IPW90R800C3 | PG-T0247 | 9R800C  |



Maximum ratings, at  $T_J=25^{\circ}\text{C}$ , unless otherwise specified

| Parameter                                      | Symbol         | Conditions                             | Value       | Unit               |
|------------------------------------------------|----------------|----------------------------------------|-------------|--------------------|
| Continuous drain current                       | $I_D$          | $T_C=25^{\circ}\text{C}$               | 6.9         | A                  |
|                                                |                | $T_C=100^{\circ}\text{C}$              | 4.4         |                    |
| Pulsed drain current <sup>2)</sup>             | $I_{D,pulse}$  | $T_C=25^{\circ}\text{C}$               | 15          |                    |
| Avalanche energy, single pulse                 | $E_{AS}$       | $I_D=1.4\text{ A}, V_{DD}=50\text{ V}$ | 157         | mJ                 |
| Avalanche energy, repetitive $t_{AR}^{2),3)}$  | $E_{AR}$       | $I_D=1.4\text{ A}, V_{DD}=50\text{ V}$ | 0.46        |                    |
| Avalanche current, repetitive $t_{AR}^{2),3)}$ | $I_{AR}$       |                                        | 1.4         | A                  |
| MOSFET dv/dt ruggedness                        | dv/dt          | $V_{DS}=0...400\text{ V}$              | 50          | V/ns               |
| Gate source voltage                            | $V_{GS}$       | static                                 | $\pm 20$    | V                  |
|                                                |                | AC ( $f>1\text{ Hz}$ )                 | $\pm 30$    |                    |
| Power dissipation                              | $P_{tot}$      | $T_C=25^{\circ}\text{C}$               | 104         | W                  |
| Operating and storage temperature              | $T_J, T_{stg}$ |                                        | -55 ... 150 | $^{\circ}\text{C}$ |
| Mounting torque                                |                | M3 and M3.5 screws                     | 60          | Ncm                |

Maximum ratings, at  $T_J=25\text{ }^{\circ}\text{C}$ , unless otherwise specified

| Parameter                           | Symbol        | Conditions                       | Value | Unit |
|-------------------------------------|---------------|----------------------------------|-------|------|
| Continuous diode forward current    | $I_S$         | $T_C=25\text{ }^{\circ}\text{C}$ | 4.1   | A    |
| Diode pulse current <sup>2)</sup>   | $I_{S,pulse}$ |                                  | 15    |      |
| Reverse diode $dv/dt$ <sup>4)</sup> | $dv/dt$       |                                  | 4     | V/ns |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

#### Thermal characteristics

|                                                            |              |                                       |   |   |     |                    |
|------------------------------------------------------------|--------------|---------------------------------------|---|---|-----|--------------------|
| Thermal resistance, junction - case                        | $R_{thJC}$   |                                       | - | - | 1.2 | K/W                |
| Thermal resistance, junction - ambient                     | $R_{thJA}$   | leaded                                | - | - | 62  |                    |
| Soldering temperature, wavesoldering only allowed at leads | $T_{solder}$ | 1.6 mm (0.063 in.) from case for 10 s | - | - | 260 | $^{\circ}\text{C}$ |

Electrical characteristics, at  $T_J=25\text{ }^{\circ}\text{C}$ , unless otherwise specified

#### Static characteristics

|                                  |               |                                                                                 |     |      |     |               |
|----------------------------------|---------------|---------------------------------------------------------------------------------|-----|------|-----|---------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}$ , $I_D=250\text{ }\mu\text{A}$                              | 900 | -    | -   | V             |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}$ , $I_D=0.46\text{ mA}$                                          | 2.5 | 3    | 3.5 |               |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=900\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=25\text{ }^{\circ}\text{C}$  | -   | -    | 1   | $\mu\text{A}$ |
|                                  |               | $V_{DS}=900\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=150\text{ }^{\circ}\text{C}$ | -   | 10   | -   |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                                      | -   | -    | 100 | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=10\text{ V}$ , $I_D=4.1\text{ A}$ , $T_J=25\text{ }^{\circ}\text{C}$    | -   | 0.62 | 0.8 | $\Omega$      |
|                                  |               | $V_{GS}=10\text{ V}$ , $I_D=4.1\text{ A}$ , $T_J=150\text{ }^{\circ}\text{C}$   | -   | 1.7  | -   |               |
| Gate resistance                  | $R_G$         | $f=1\text{ MHz}$ , open drain                                                   | -   | 1.3  | -   | $\Omega$      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

#### Dynamic characteristics

|                                                            |              |                                                                                                  |   |      |   |    |
|------------------------------------------------------------|--------------|--------------------------------------------------------------------------------------------------|---|------|---|----|
| Input capacitance                                          | $C_{iss}$    | $V_{GS}=0\text{ V}$ , $V_{DS}=100\text{ V}$ ,<br>$f=1\text{ MHz}$                                | - | 1100 | - | pF |
| Output capacitance                                         | $C_{oss}$    |                                                                                                  | - | 52   | - |    |
| Effective output capacitance, energy related <sup>5)</sup> | $C_{o(er)}$  | $V_{GS}=0\text{ V}$ , $V_{DS}=0\text{ V}$<br>to 500 V                                            | - | 34   | - |    |
| Effective output capacitance, time related <sup>6)</sup>   | $C_{o(tr)}$  |                                                                                                  | - | 130  | - |    |
| Turn-on delay time                                         | $t_{d(on)}$  | $V_{DD}=400\text{ V}$ ,<br>$V_{GS}=10\text{ V}$ , $I_D=4.1\text{ A}$ ,<br>$R_G=50\text{ }\Omega$ | - | 70   | - | ns |
| Rise time                                                  | $t_r$        |                                                                                                  | - | 20   | - |    |
| Turn-off delay time                                        | $t_{d(off)}$ |                                                                                                  | - | 400  | - |    |
| Fall time                                                  | $t_f$        |                                                                                                  | - | 32   | - |    |

#### Gate Charge Characteristics

|                       |               |                                                                                  |   |     |     |    |
|-----------------------|---------------|----------------------------------------------------------------------------------|---|-----|-----|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=400\text{ V}$ , $I_D=4.1\text{ A}$ ,<br>$V_{GS}=0\text{ to }10\text{ V}$ | - | 5   | -   | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                                                  | - | 18  | -   |    |
| Gate charge total     | $Q_g$         |                                                                                  | - | 42  | tbd |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                                                  | - | 4.6 | -   | V  |

#### Reverse Diode

|                               |           |                                                                              |   |     |     |               |
|-------------------------------|-----------|------------------------------------------------------------------------------|---|-----|-----|---------------|
| Diode forward voltage         | $V_{SD}$  | $V_{GS}=0\text{ V}$ , $I_F=4.1\text{ A}$ ,<br>$T_J=25\text{ }^\circ\text{C}$ | - | 0.8 | 1.2 | V             |
| Reverse recovery time         | $t_{rr}$  | $V_R=400\text{ V}$ , $I_F=I_S$ ,<br>$di_F/dt=100\text{ A}/\mu\text{s}$       | - | 360 | -   | ns            |
| Reverse recovery charge       | $Q_{rr}$  |                                                                              | - | 5.3 | -   | $\mu\text{C}$ |
| Peak reverse recovery current | $I_{rrm}$ |                                                                              | - | 24  | -   | A             |

<sup>1)</sup> J-STD20 and JESD22

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{J,max}$

<sup>3)</sup> Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV}=E_{AR} \cdot f$ .

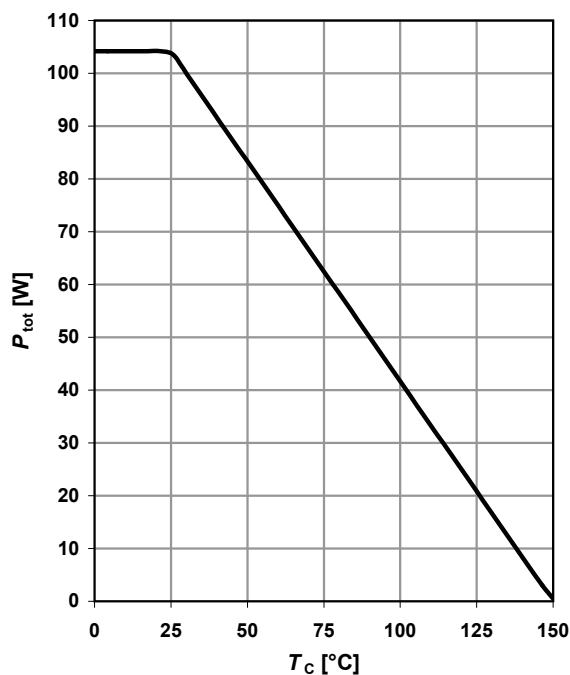
<sup>4)</sup>  $I_{SD} \leq I_D$ ,  $di/dt \leq 200\text{ A}/\mu\text{s}$ ,  $V_{DClamp}=400\text{ V}$ ,  $V_{peak} < V_{(BR)DSS}$ ,  $T_J < T_{J,max}$ , identical low side and high side switch

<sup>5)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 50%  $V_{DSS}$ .

<sup>6)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 50%  $V_{DSS}$ .

### 1 Power dissipation

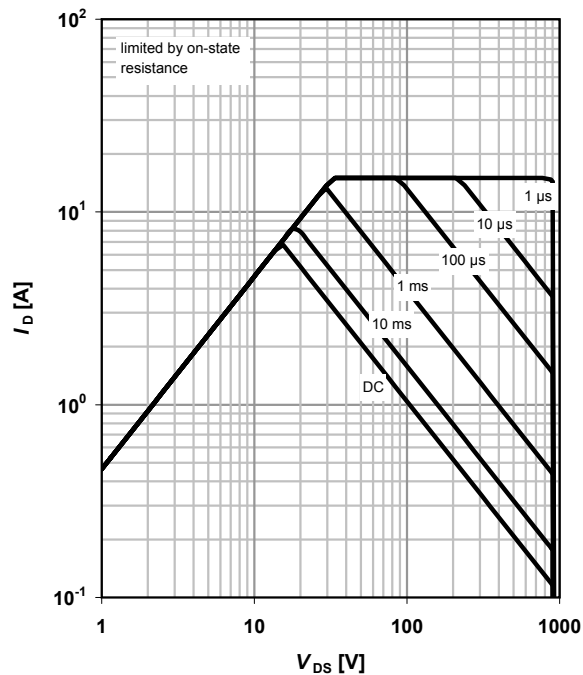
$$P_{\text{tot}} = f(T_C)$$



### 2 Safe operating area

$$I_D = f(V_{DS}; T_C = 25^\circ\text{C}; D = 0)$$

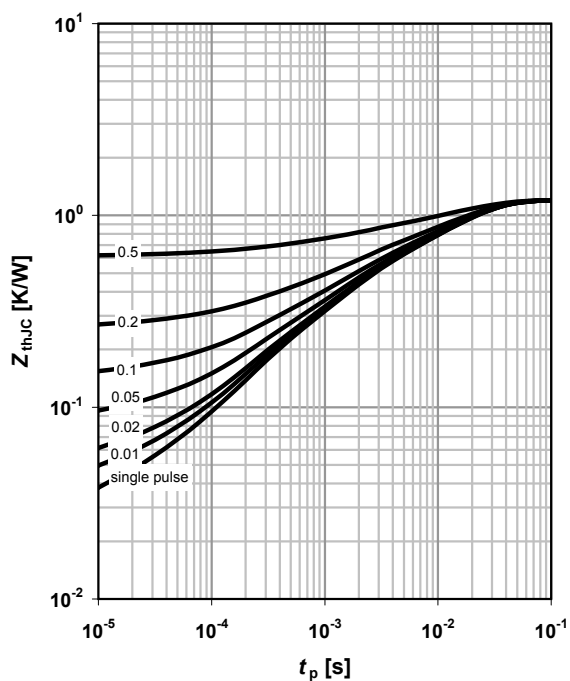
parameter:  $t_p$



### 3 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

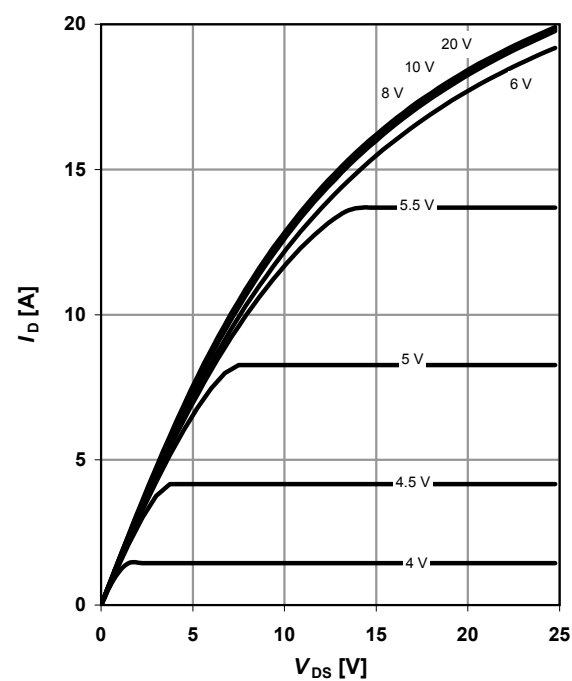
parameter:  $D = t_p / T$



### 4 Typ. output characteristics

$$I_D = f(V_{DS}; T_J = 25^\circ\text{C})$$

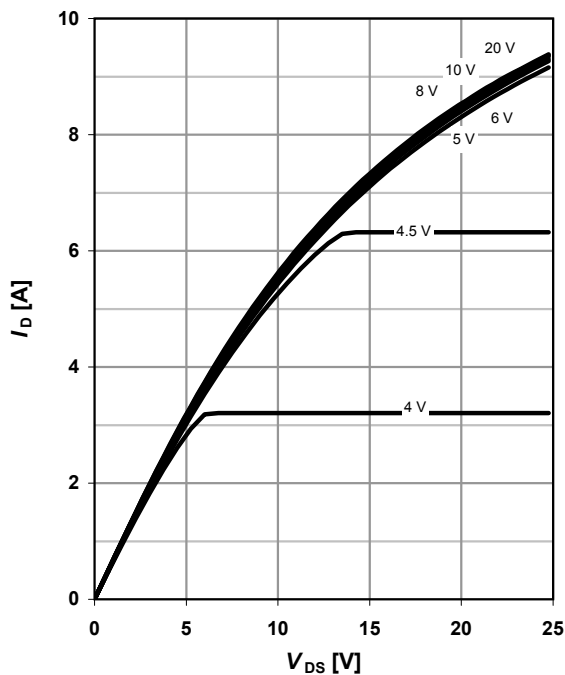
parameter:  $V_{GS}$



### 5 Typ. output characteristics

$$I_D = f(V_{DS}); T_J = 150^\circ\text{C}$$

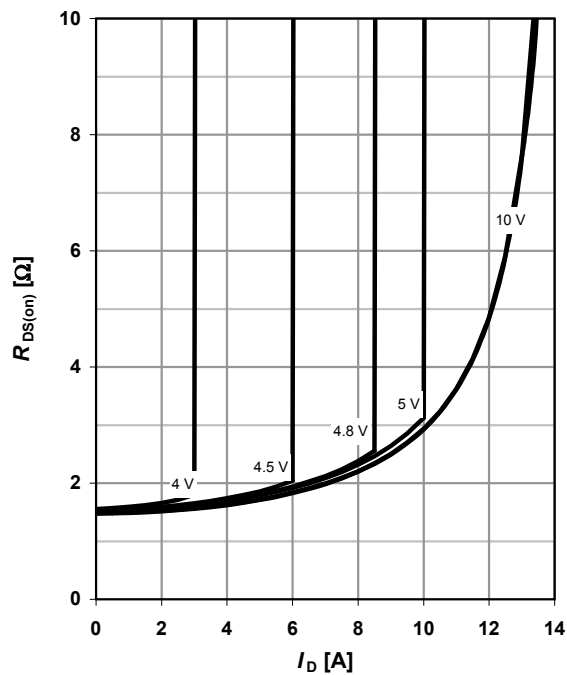
parameter:  $V_{GS}$



### 6 Typ. drain-source on-state resistance

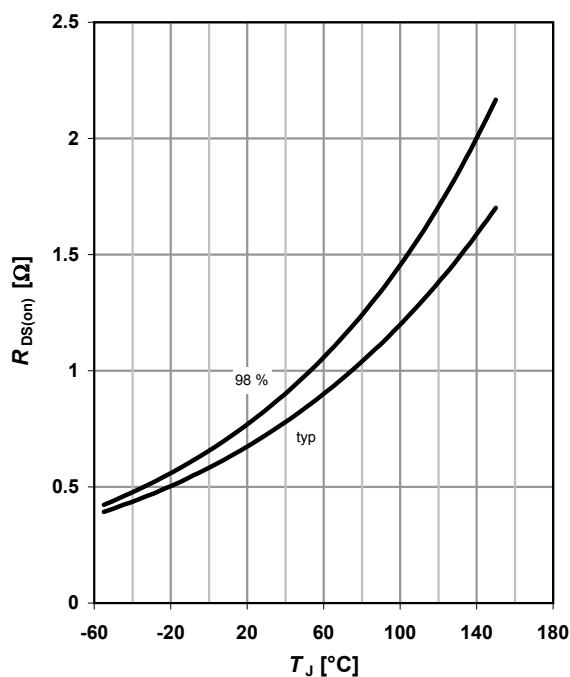
$$R_{DS(on)} = f(I_D); T_J = 150^\circ\text{C}$$

parameter:  $V_{GS}$



### 7 Drain-source on-state resistance

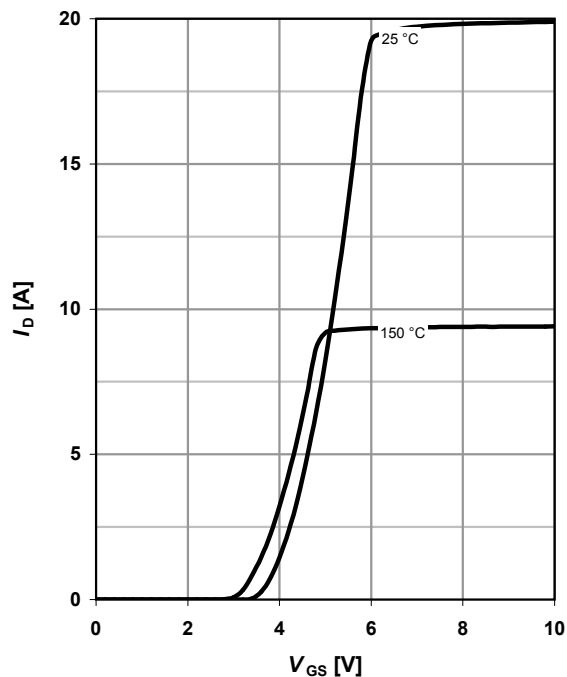
$$R_{DS(on)} = f(T_J); I_D = 4.1\text{ A}; V_{GS} = 10\text{ V}$$



### 8 Typ. transfer characteristics

$$I_D = f(V_{GS}); V_{DS} = 20\text{ V}$$

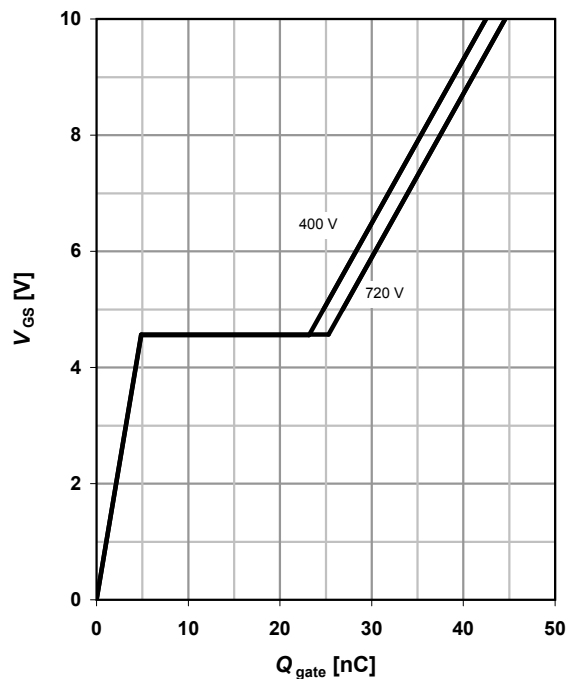
parameter:  $T_J$



### 9 Typ. gate charge

$$V_{GS}=f(Q_{gate}); I_D=4.1 \text{ A pulsed}$$

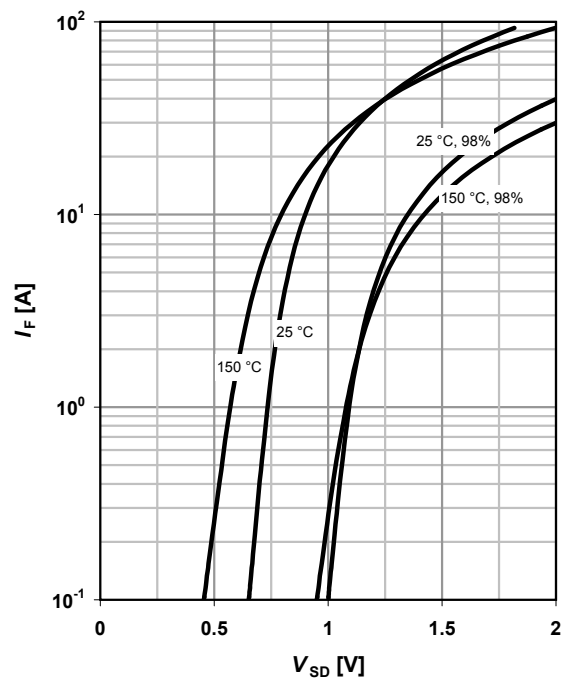
parameter:  $V_{DD}$



### 10 Forward characteristics of reverse diode

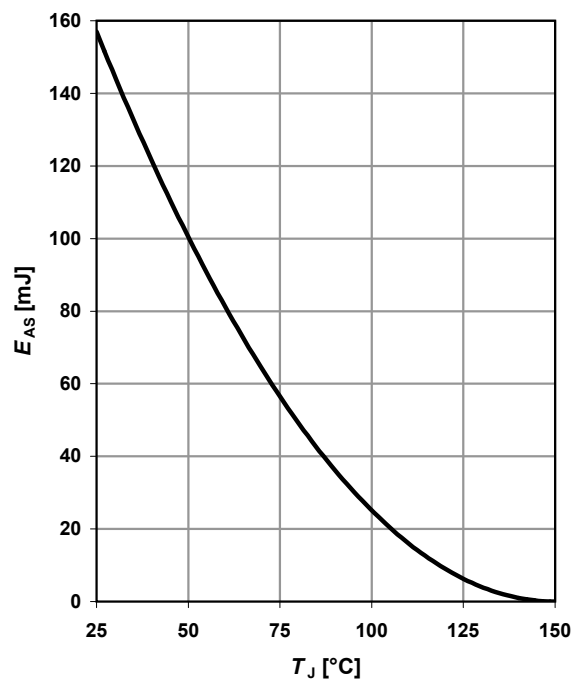
$$I_F=f(V_{SD})$$

parameter:  $T_J$



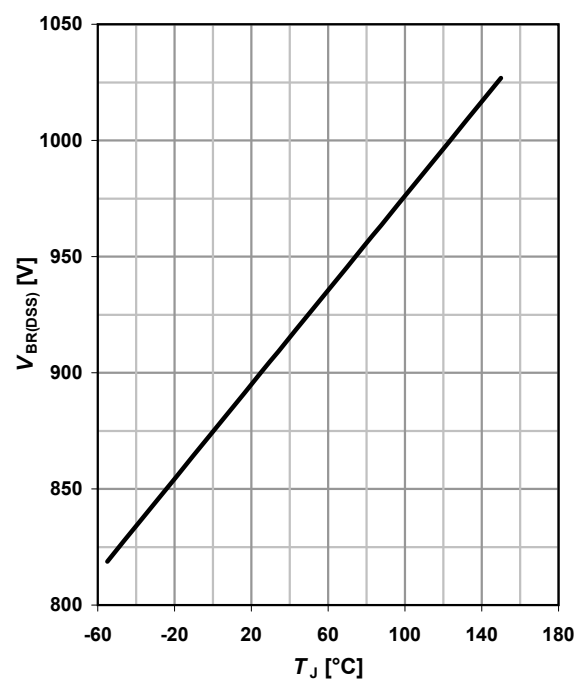
### 11 Avalanche energy

$$E_{AS}=f(T_J); I_D=1.4 \text{ A}; V_{DD}=50 \text{ V}$$

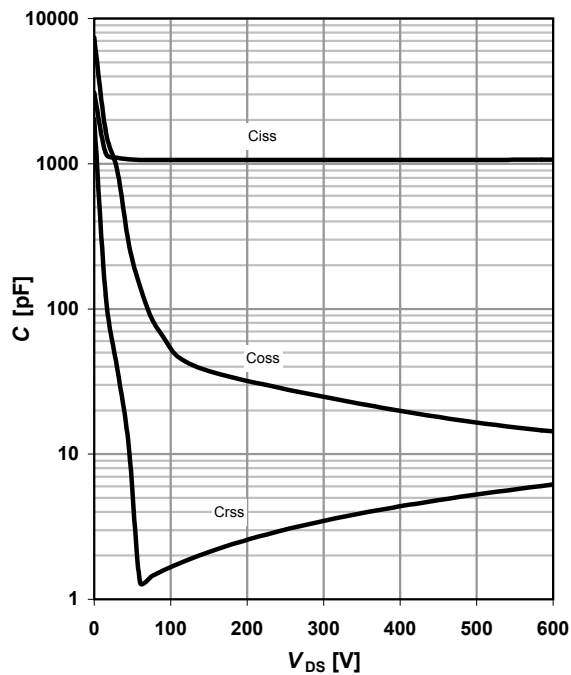


### 12 Drain-source breakdown voltage

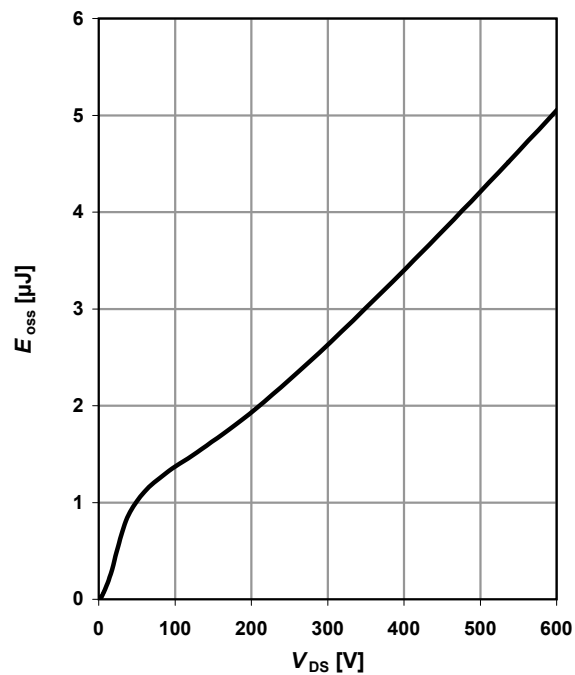
$$V_{BR(DSS)}=f(T_J); I_D=0.25 \text{ mA}$$



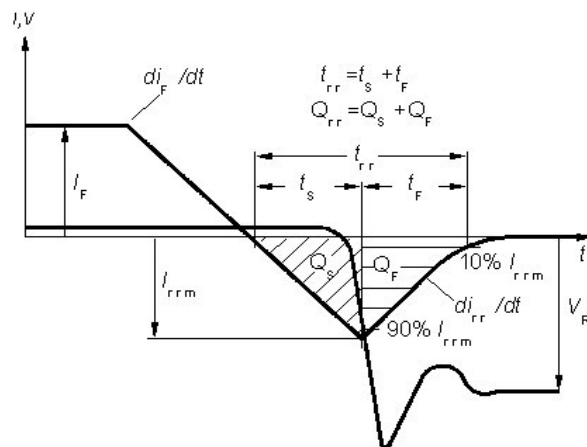
### 13 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$ 


### 14 Typ. $C_{oss}$ stored energy

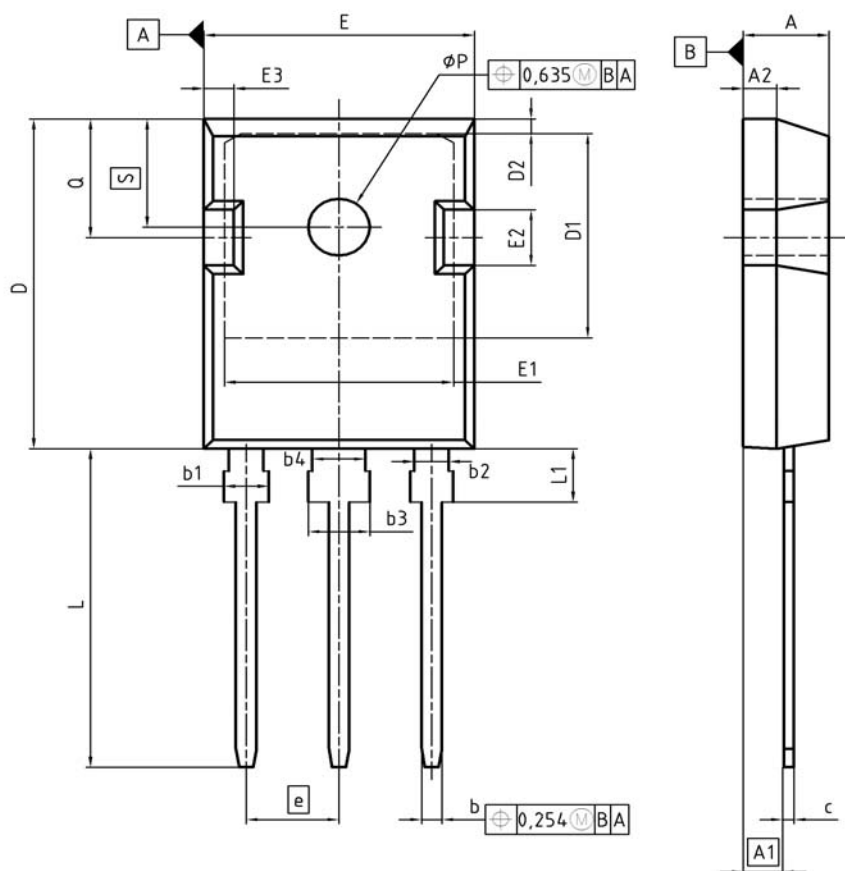
 $E_{oss} = f(V_{DS})$ 


# Definition of diode switching characteristics

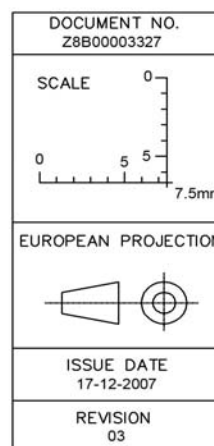




## PG-TO247 Outlines



| DIM | MILLIMETERS |       | INCHES |       |
|-----|-------------|-------|--------|-------|
|     | MIN         | MAX   | MIN    | MAX   |
| A   | 4.90        | 5.16  | 0.193  | 0.203 |
| A1  | 2.27        | 2.53  | 0.089  | 0.099 |
| A2  | 1.85        | 2.11  | 0.073  | 0.083 |
| b   | 1.07        | 1.33  | 0.042  | 0.052 |
| b1  | 1.90        | 2.41  | 0.075  | 0.095 |
| b2  | 1.90        | 2.16  | 0.075  | 0.085 |
| b3  | 2.87        | 3.38  | 0.113  | 0.133 |
| b4  | 2.87        | 3.13  | 0.113  | 0.123 |
| c   | 0.55        | 0.68  | 0.022  | 0.027 |
| D   | 20.82       | 21.10 | 0.820  | 0.831 |
| D1  | 16.25       | 17.65 | 0.640  | 0.695 |
| D2  | 1.05        | 1.35  | 0.041  | 0.053 |
| E   | 15.70       | 16.03 | 0.618  | 0.631 |
| E1  | 13.10       | 14.15 | 0.516  | 0.557 |
| E2  | 3.68        | 5.10  | 0.145  | 0.201 |
| E3  | 1.68        | 2.60  | 0.066  | 0.102 |
| e   | 5.44        |       | 0.214  |       |
| N   | 3           |       | 3      |       |
| L   | 19.80       | 20.31 | 0.780  | 0.799 |
| L1  | 4.17        | 4.47  | 0.164  | 0.176 |
| øP  | 3.50        | 3.70  | 0.138  | 0.146 |
| Q   | 5.49        | 6.00  | 0.216  | 0.236 |
| S   | 6.04        | 6.30  | 0.238  | 0.248 |



Dimensions in mm/inches

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## 1 New package outlines TO-247

Assembly capacity extension for CoolMOSTM technology products assembled in lead-free package  
PG-TO247-3 at subcontractor ASE (Weihai) Inc., China (Changes are marked in blue.)

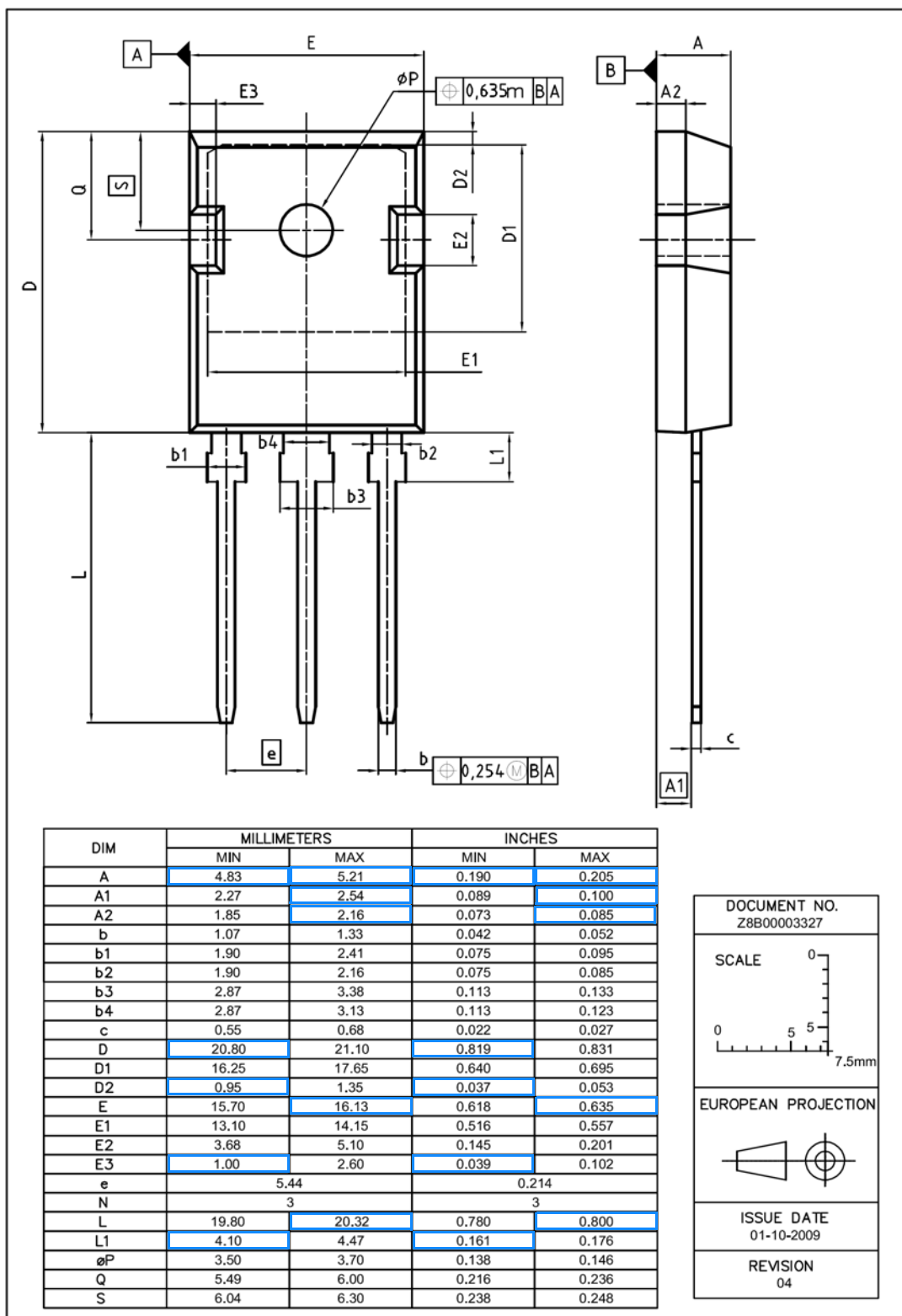


Figure 1 Outlines TO-247, dimensions in mm/inches